

**University of Basrah
College of Education for Pure Sciences
Department of Chemistry**

**Ph.D Physical Course
2nd term "2020-2021"**

- 1. Introduction to X-rays.**
- 2. Generation of X-rays.**
- 3. Why X-rays?**
- 4. Principle of X-rays.**
- 5. Instrumentation of X-rays.**
- 6. Production of X-rays.**
- 7. X-rays diffraction methods.**
- 8. Solid state.**
- 9. Basics of crystallography.**
- 10. Miller indices (hkl).**
- 11. Peak position.**
- 12. Debye-Scherrer equation.**
- 13. Applications of XRD.**

References:

- 1. Solid State Physics , J. Moore**
- 2. Solid State Chemistry and applications , A. R. West**
- 3. Physical Chemistry , Atkins**
- 4. Internet.**

Prof. Dr. Mohanad J. K. Al. Asadi

INTRODUCTION:

X-rays were discovered by Wilhelm Roentgen

Nov. 1895



who called them x-rays because the nature at first was unknown so, x-rays are also called Roentgen rays. X-ray diffraction in crystals was discovered by Max von Laue. The wavelength range is 10^{-7} to about 10^{-15} m.

The penetrating power of x-rays depends on energy also, there are two types of x-rays.

- i) **Hard x-rays:** which have high frequency and have more energy.
- ii) **soft x-rays:** which have less penetrating and have low energy



Max Von
Laue

X-RAYS

1. X-rays are short wave length electromagnetic radiations produced by the deceleration of high energy electrons or by electronic transitions of electrons in the inner orbital of atoms

2. X-ray region 0.1 to 100 Å

3. Analytical purpose 0.7 to 2 Å

$$1 \text{ \AA} = 1 \times 10^{-10} \text{ m}$$
$$1 \text{ m} = 1 \times 10^9 \text{ nm}$$
$$1 \text{ \AA} = 0.1 \text{ nm}$$

هذه أطوال موجات كهرومغناطيسية ذات طول موجي صغير تنتج عند تباطؤ الإلكترونات أو التصادمات ذات الطاقة العالية أو عند تحولات المدارات الإلكترونية في الذرات
منطقة الأشعة السينية تكون من 0.1 - 100 Å
الغرض التحليلي من 0.7 - 2 Å

PRINCIPLE

X-ray diffraction is based on constructive interference of monochromatic x-rays and a crystalline sample. These x-rays are generated by a cathode ray tube, filtered to produce monochromatic radiation, collimated to concentrate and directed towards the sample. The interaction of incident rays with the sample produces constructive interference when conditions satisfy **Bragg's law**.

لقد عيود لا تتفر إلى سعة السعة لم لتأخر لتبدأ لا تتفر إلى سعة السعة العادية للون
والصحة للبورصة / تتفر هذه لا تتفر إلى سعة السعة العادية للون
الذي يربطه لانتاج سعة السعة العادية للون الموازي للذرات وتوجهه نحو السعة
و يتفر منه $n\lambda$ لتقاله لا تتفر إلى سعة السعة العادية للون الموازي للذرات وتوجهه نحو السعة
الظروف متأخر في بر لاغ

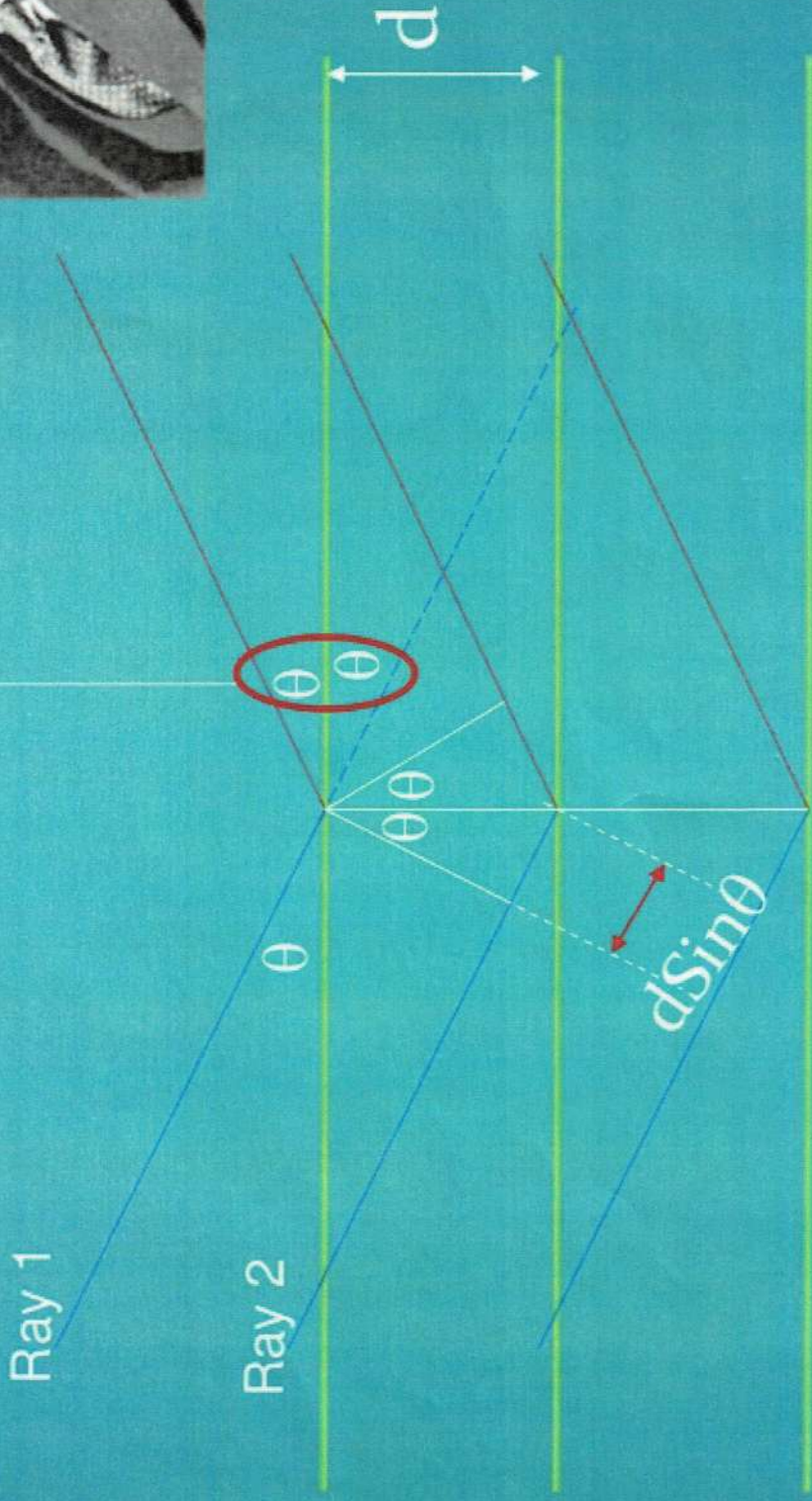
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BRAGG'S EQUATION



Deviation = 2θ



The path difference between ray 1 and ray 2 = $2d \sin \theta$

For constructive interference: $n\lambda = 2d \sin \theta$

Constructive interference of the reflected beams emerging from two different planes will take place if the path lengths of two rays is equal to whole number of wavelengths”.

for constructive interference,

$$n\lambda = 2d \sin \theta$$

this is called as BRAGG'S LAW

- كل ذلك يتوافق مع مبدأ التداخل البناء للضوء المنعكس من الطبقات المختلفة ، ما إذا كانت أطوال صيغ
الضوئية متساوية ، كما هو الحال في "كامل" من أطوال الطبقات ، بالنسبة للتداخل البناء ، فهذا يحقق
توافقاً بمرجع .

BRAGG'S LAW:

After few months, In 1913, English physicists **Sir William Henry Bragg** and his son **Sir William Lawrence Bragg** developed a relationship to explain why the cleavage faces of crystals appear to reflect X-ray beams at certain angles of incidence (θ).

The variable d is the distance between atomic layers in a crystal, and the variable λ is the wavelength of the incident X-ray beam; n is an integer.

Although Bragg's law was used to explain the interference pattern of X-rays scattered by crystals, diffraction has been developed to study the structure of all states of matter with any beam.

Bragg carried out a series of experiments, the result of which he published the Bragg equation -

$$n \lambda = 2 d \sin \theta$$

where, assume $n = 1$ for the first order reflection

= wavelength

= X-ray incidence angle

= distance between atomic layer